International **ICR** Rectifier

POWER MOSFET THRU-HOLE (TO-254AA)

Product Summary

Part Number	RDS(on)	ID
IRFM240	0.18 Ω	18A

HEXFET® MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.

PD - 90555D

IRFM240 JANTX2N7219 JANTXV2N7219 REF:MIL-PRF-19500/596 200V, N-CHANNEL HEXFET[®] MOSFETTECHNOLOGY



Features:

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Dynamic dv/dt Rating
- Light-weight

	Parameter		Units	
ID @ VGS = 10V, TC = 25°C	Continuous Drain Current	18		
ID @ VGS = 10V, TC = 100°C Continuous Drain Current		11	A	
IDM	Pulsed Drain Current ①	72	1	
P _D @ T _C = 25°C	Max. Power Dissipation	125	W	
	Linear Derating Factor	1.0	W/°C	
VGS	Gate-to-Source Voltage	±20	V	
EAS	Single Pulse Avalanche Energy 2	450	mJ	
IAR	Avalanche Current ①	18	A	
EAR	Repetitive Avalanche Energy ①	12.5	mJ	
dv/dt	Peak Diode Recovery dv/dt 3	5.0	V/ns	
TJ	Operating Junction	-55 to 150		
TSTG	Storage Temperature Range		°C	
	Lead Temperature	300 (0.063 in.(1.6mm) from case for 10s)		
	Weight	2.6 (Typical)	g	

Absolute Maximum Ratings

For footnotes refer to the last page

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Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

	Parameter	Min	Тур	Мах	Units	Test Conditions
BVDSS	Drain-to-Source Breakdown Voltage	200	—	_	V	VGS = 0V, ID = 1.0mA
$\Delta BV_{DSS}/\Delta T_{J}$	Temperature Coefficient of Breakdown Voltage	—	0.29	—	V/°C	Reference to 25°C, $I_D = 1.0$ mA
RDS(on)	Static Drain-to-Source On-State	_	—	0.18	Ω	VGS = 10V, ID = 11A (4)
	Resistance	—	—	0.25	32	V _{GS} = 10V, I _D = 18A
VGS(th)	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$
9fs	Forward Transconductance	6.1	—	—	S(7)	V _{DS} > 15V, I _{DS} = 11A ④
IDSS	Zero Gate Voltage Drain Current	—	—	25	μA	V _{DS} = 160V ,V _{GS} =0V
		—	—	250	μΑ	V _{DS} = 160V,
						$V_{GS} = 0V, T_{J} = 125^{\circ}C$
IGSS	Gate-to-Source Leakage Forward	_	—	100	nA	VGS = 20V
IGSS	Gate-to-Source Leakage Reverse		—	-100		V _{GS} = -20V
Qg	Total Gate Charge	_	—	60		VGS =10V, ID = 18A
Qgs	Gate-to-Source Charge	—	—	10.6	nC	$V_{DS} = 100V$
Q _{gd}	Gate-to-Drain ('Miller') Charge	_	—	37.6		
^t d(on)	Turn-On Delay Time		—	20		V _{DD} = 100V, I _D = 18A,
tr	Rise Time		—	105	ns	V_{GS} =10V, R_{G} = 9.1 Ω
^t d(off)	Turn-Off Delay Time	_	—	58	115	
tf	Fall Time	—	—	67		
L _S +L _D	Total Inductance	_	4.0	_	nH	Measured from drain lead (6mm/ 0.25in. from package) to source lead (6mm/0.25in. from package)
C _{iss}	Input Capacitance		1300	_		$V_{GS} = 0V, V_{DS} = 25V$
C _{OSS}	Output Capacitance	_	400	—	pF	f = 1.0MHz
C _{rss}	Reverse Transfer Capacitance	_	130	—		

Source-Drain Diode Ratings and Characteristics

	Parameter		Min	Тур	Max	Units	Test Conditions
IS	Continuous Source Current (B	Body Diode)		_	18	٨	
ISM	Pulse Source Current (Body D	Diode) ①		—	72	A	
VSD	Diode Forward Voltage		_	—	1.5	V	$T_j = 25^{\circ}C, I_S = 18A, V_{GS} = 0V $
trr	Reverse Recovery Time		-	_	500	nS	Tj = 25°C, IF = 18A, di/dt ≤ 100A/μs
QRR	Reverse Recovery Charge		-	—	5.3	μC	$V_{DD} \leq 50V @$
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_S+L_D.$					

Thermal Resistance

	Parameter	Min	Тур	Max	Units	Test Conditions
RthJC	Junction-to-Case	_	_	1.0		
RthJS	Case-to-sink	—	0.21	_	°C/W	
R _{th} JA	Junction-to-Ambient	—	—	48		Typical socket mount

Note: Corresponding Spice and Saber models are available on the G&S Website.

For footnotes refer to the last page

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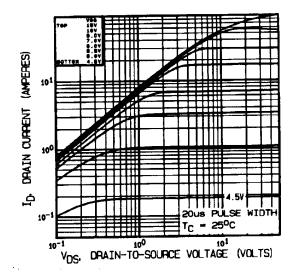


Fig 1. Typical Output Characteristics

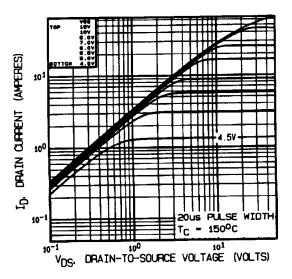


Fig 2. Typical Output Characteristics

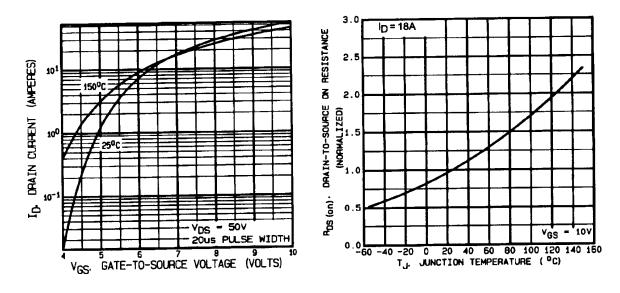
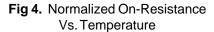


Fig 3. Typical Transfer Characteristics



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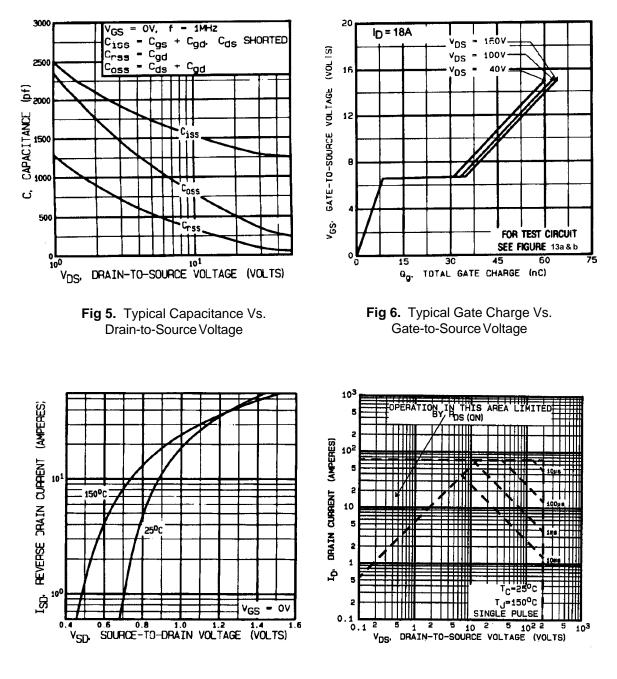
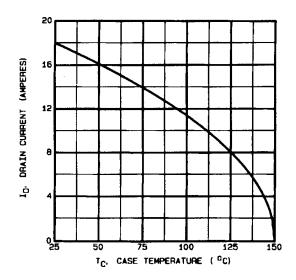
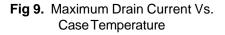


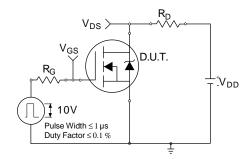
Fig 7. Typical Source-Drain Diode Forward Voltage

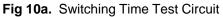
Fig 8. Maximum Safe Operating Area

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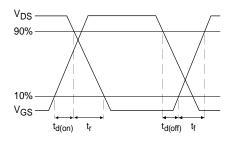


Fig 10b. Switching Time Waveforms

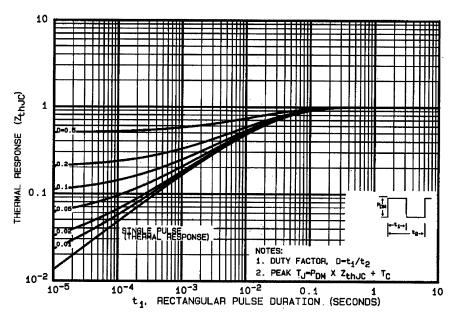


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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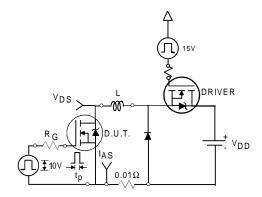


Fig 12a. Unclamped Inductive Test Circuit

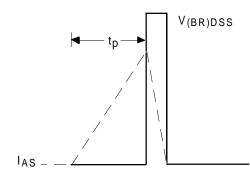


Fig 12b. Unclamped Inductive Waveforms

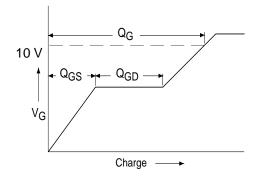


Fig 13a. Basic Gate Charge Waveform

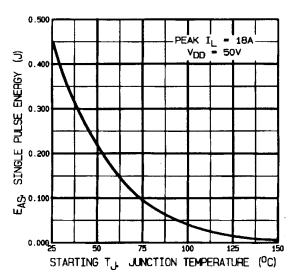


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

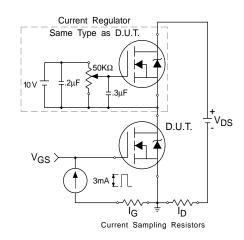


Fig 13b. Gate Charge Test Circuit

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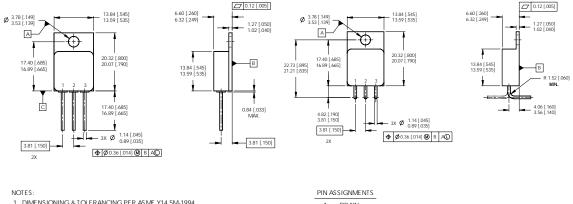
Footnotes:

① Repetitive Rating; Pulse width limited by maximum junction temperature.

② VDD = 50V, starting TJ = 25°C, L= 1.3mH Peak I_L = 18A, V_{GS} = 10V

- $3 \text{ ISD} \leq 18 \text{ A}, \text{ di/dt} \leq 150 \text{ A/} \mu \text{s},$ $V_{DD} \le 200V, T_{J} \le 150^{\circ}C$
- ④ Pulse width \leq 300 µs; Duty Cycle \leq 2%

Case Outline and Dimensions — TO-254AA



1. DIMENSIONING & TOLERANCING PER AS ME Y14.5M-1994

ALL DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]. CONTROLLING DIMENSION: INCH.

3. 4. CONFORMS TO JEDEC OUTLINE TO-254AA

1 = DRAN 2 = SOURCE 3 = GATE

CAUTION BERYLLIA WARNING PER MIL-PRF-19500

Packages containing beryllia shall not be ground, sandblasted, machined or have other operations performed on them which will produce beryllia or beryllium dust. Furthermore, beryllium oxide packages shall not be placed in acids that will produce fumes containing beryllium.

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